Issue Classification | 10585094



CLASS

423

ORIGINAL

447.1

Application/Control No.	

HENG M CHAN

SUBCLASS

Examiner Art Unit

1793

9 / 12 (2008.01.01)

CLAIMED

INTERNATIONAL CLASSIFICATION

Applicant(s)/Patent Under Reexamination
PENICAUD ET AL.

NON-CLAIMED

l		CROS	3 KEFE	RENCE	(3)			П	_[Г						П	\Box			
CLASS	6	SUBCLA	ASS (ONE	SUBCLA	SS PER B	LOCK)	\neg	Т	\neg								П	П			
423	447.2	44	8	449.1	460	461															
423	4458																				
								Т									П	П			
								\Box													
								\perp													
								_	_		_						_	Ш			
							_	4	_		_					_	_	ш			
							_	4	_		_					-	_	\vdash			
	_					_	-	+	\dashv		_					-	-	\vdash			
	+	_			+	_	+	+	\dashv		_	-			_	-	⊢	\vdash			
-	+						+	+	\dashv		\vdash					\vdash	\vdash	\vdash	_		
	-		_		+	_	+	+	\dashv		\vdash	-				⊢	⊢	\vdash			
	_	_				_	_	_	_			<u> </u>				_	_	ш			
											_				_	_	_				
	Claims re	enumper	ea in the	same orde	er as prese	ented by a	аррис	ant				CF	'A [] T.	υ.			K	₹.1.4	17	
Final	Original	Final	Original	Final	Original	Final	Origi	inal		Final		Original	Final	Origina	al	Fina	d	Origin	al	Final	Original
2	3								Г								\equiv				
	4								┖						4		_		_		
	5								┖		_				4		_		_		
	- 6			_					┺		_				4		_		_		
- 1	7			1					₽		_				-+		_		_		
3	9			_					₽		_				4		_		_		
4	10		-	├	-	.	-		┺		-		 		-		_		-1		
- 5 - 6	12		+	+	-	-	-		⊢		-			-			+		-1		_
	17	ı		1	1		1				- 1			1	- 1						

/HENG M CHAN/ Examiner.Art Unit 1793	11/10/2009	Total Claims Allowed:				
(Assistant Examiner)	(Date)					
/JERRY LORENGO/ Supervisory Patent Examiner.Art Unit 1793	11/12/2009	O.G. Print Claim(s)	O.G. Print Figure			
(Primary Examiner)	(Date)	1	none			

18 19